

Search Notes

Application/Control No.

10/021,495

Examiner

Annan Q. Shang

Applicant(s)/Patent under
Reexamination

SONY

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
725	37- 61,68,85,1 00,131,13 9,151	1/20/2006	A.S.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR